

Rare-earth plasma extreme ultraviolet sources at 6.5-6.7 nm for next generation semiconductor lithography

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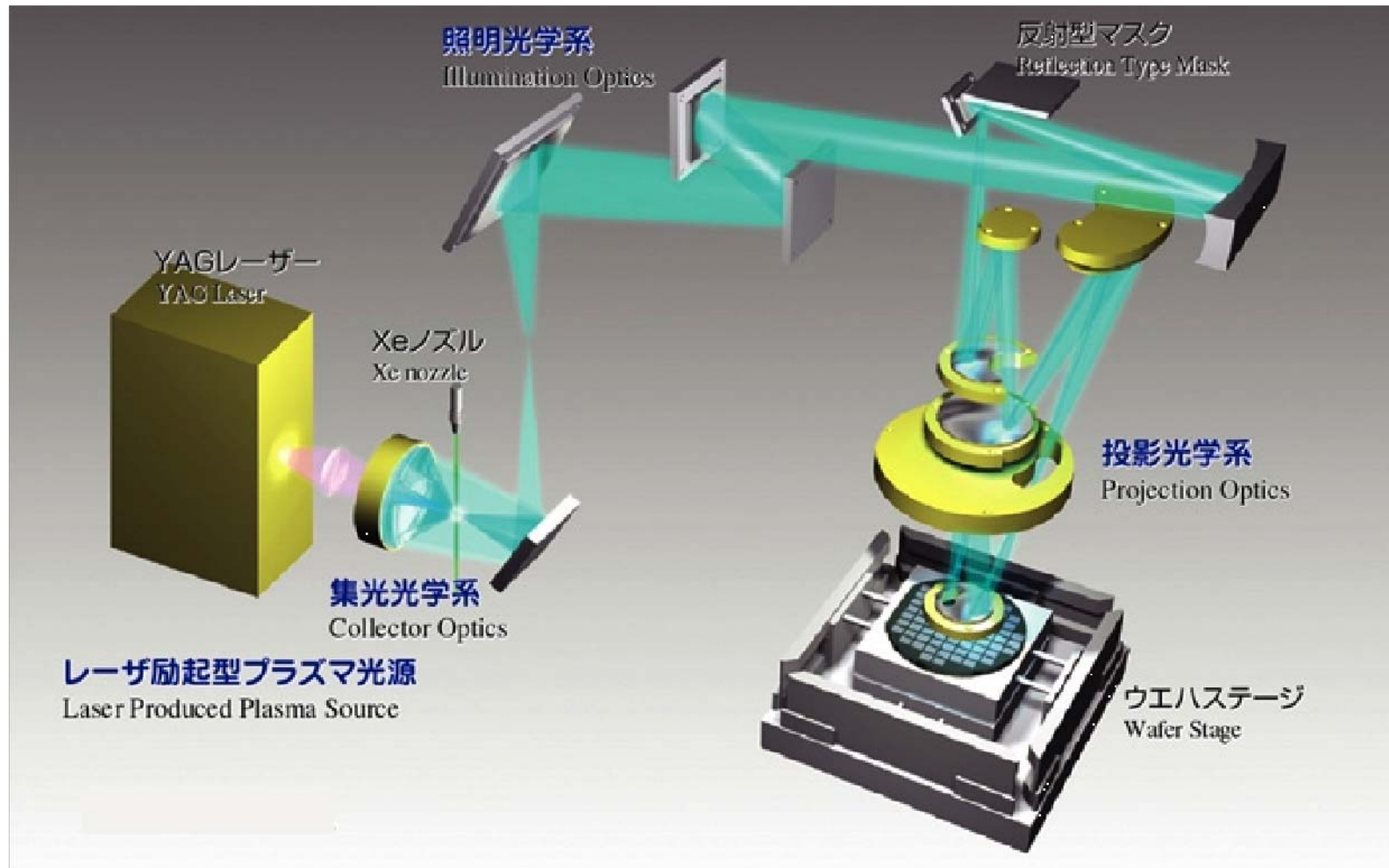
⁵Forschungszentrum Dresden

CORE



2010 International Workshop on EUV Sources
University College Dublin, Belfield, Dublin 4, Ireland
Sunday 14 November, 2010, 4:30 PM – 6:00 PM

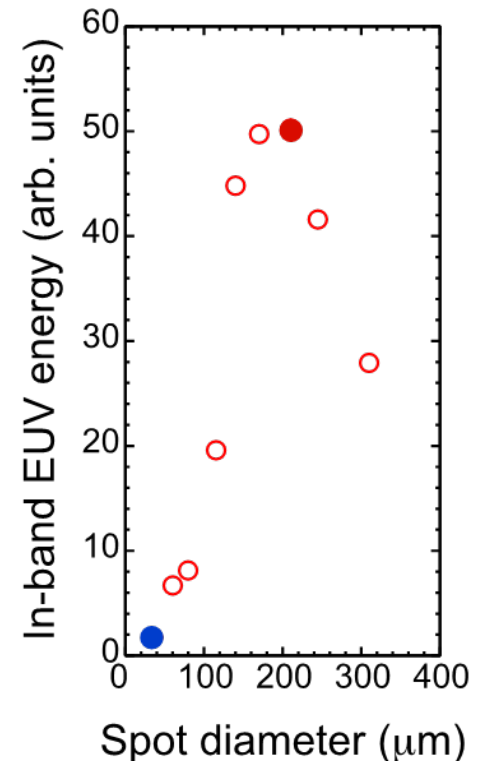
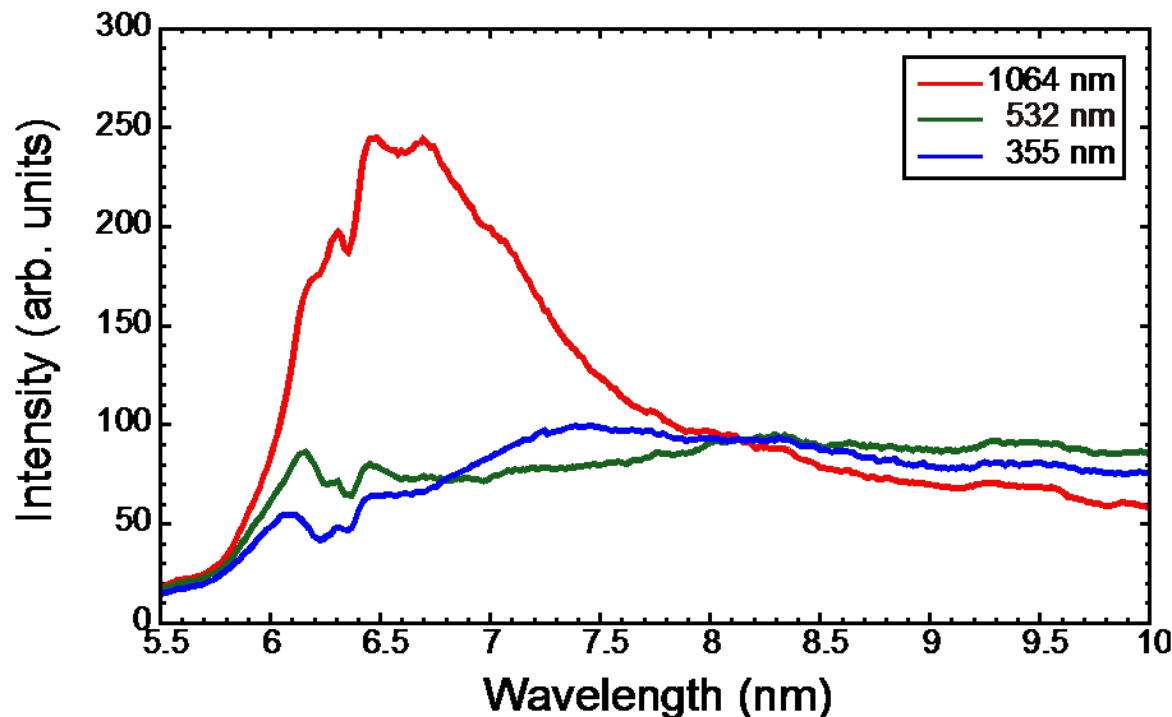
EUV lithography



http://www.euva.or.jp/technical_info/tool.html

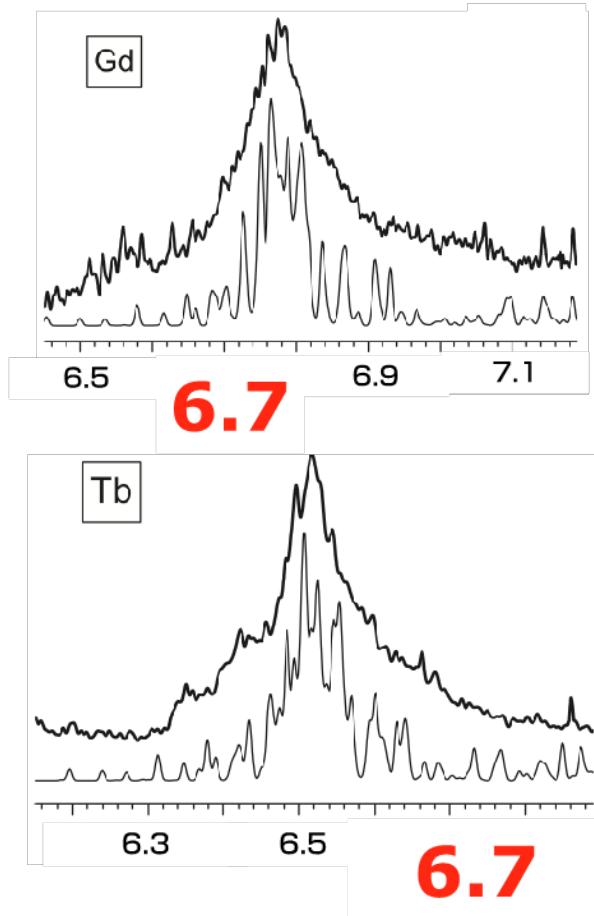
What's new for high power and high CE

- Laser color dependence
- Initial target density dependences
- Enhancement condition of the 6.7-nm emission

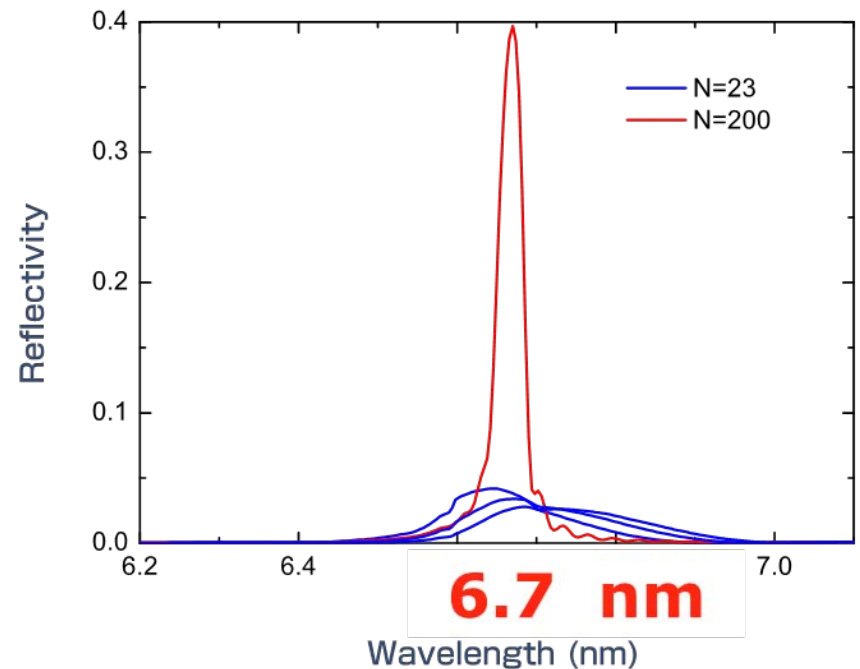


Introduction... from previous presentation

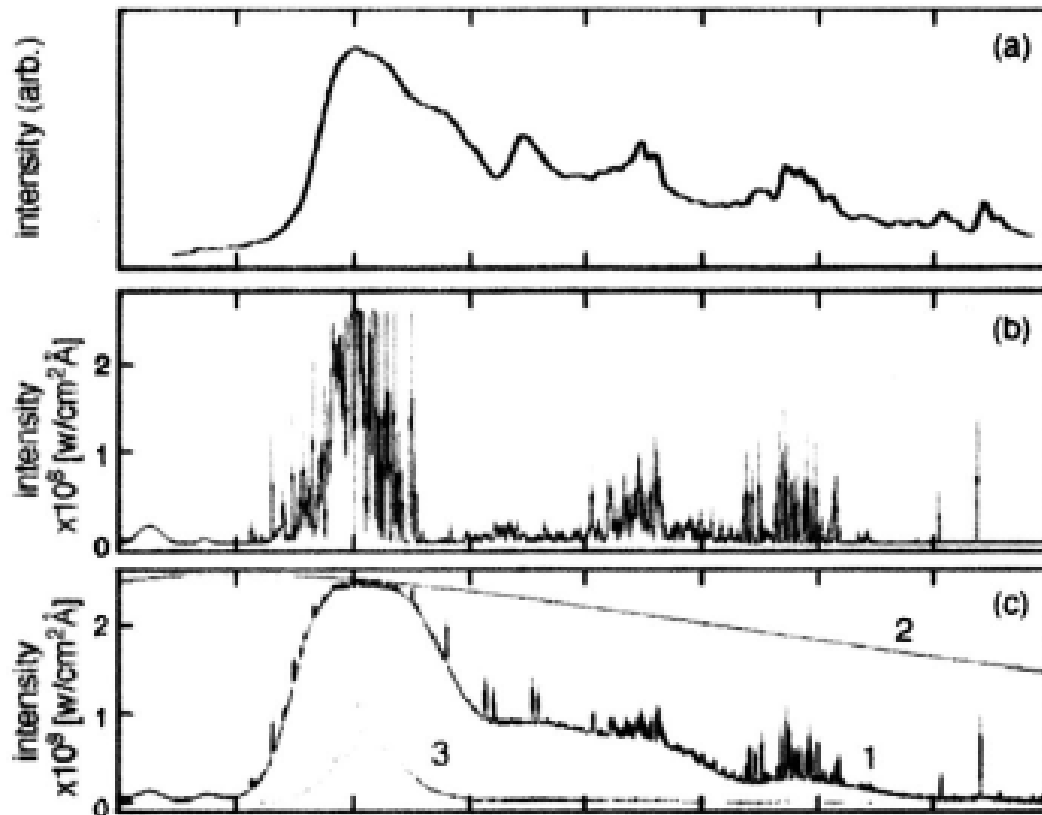
6.7 nm: Gd, Tb plasmas



Mo/B₄C mirror



***However...we have a question!!!
May we observe spectral structure like Sn & Xe
if we use the high-Z targets such as Gd & Tb?***



Experiment @EUVA, Japan

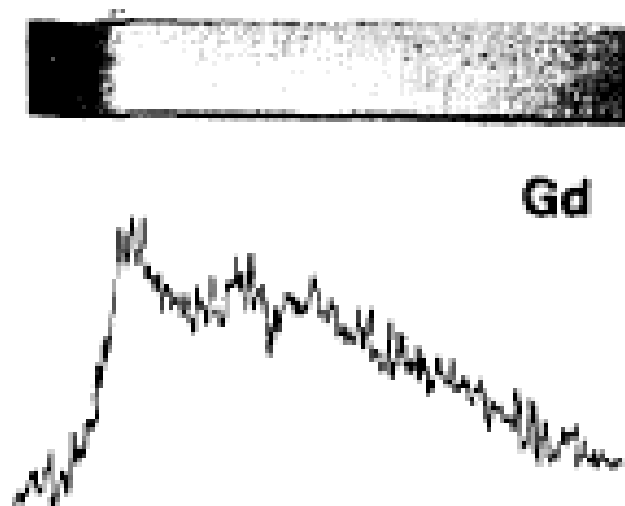
Calculation w/o satellite lines

Calculation w/ satellite lines

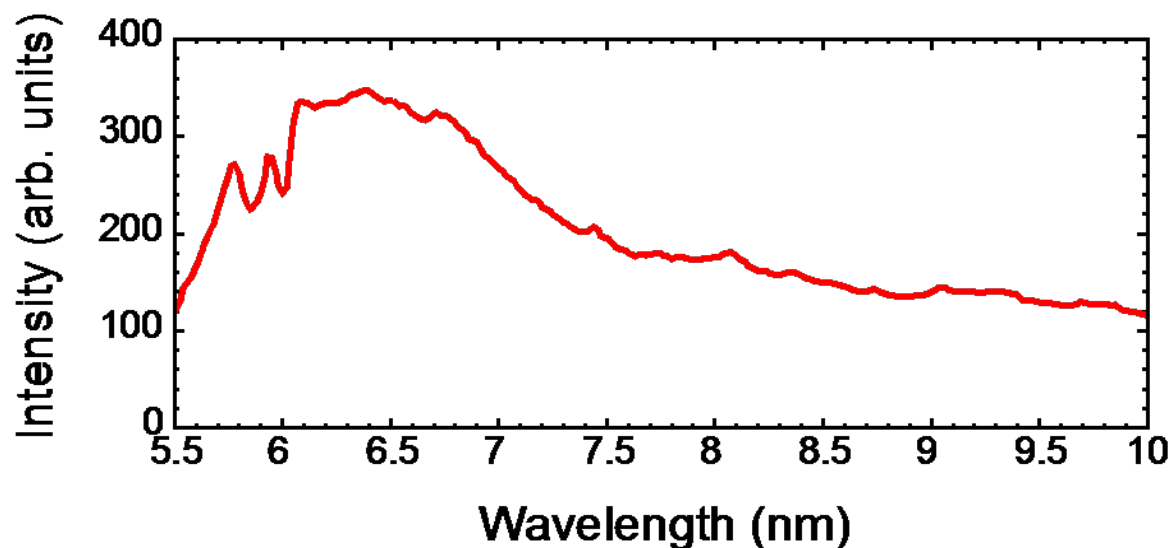
Previous & recent observations

We observed continuum due to satellite lines

for absorption spectroscopy



for high power source by us



G. O'Sullivan & P. K. Carroll, JOSA **71**, 227 (1981).

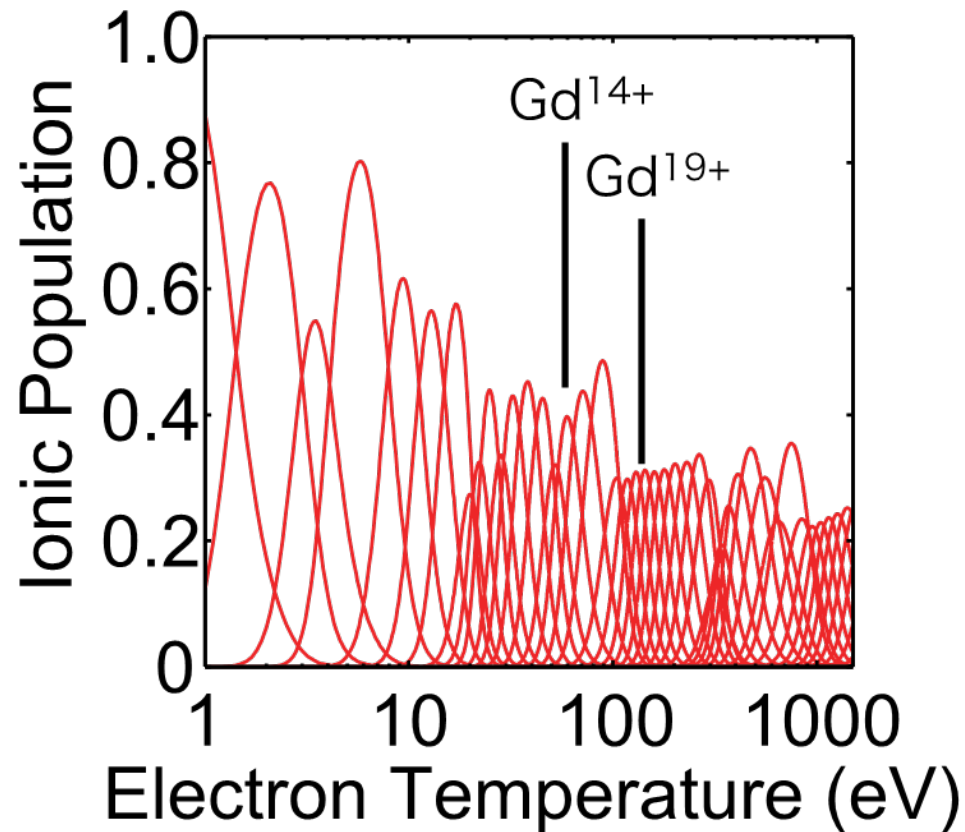
T. Otsuka *et al.*, APL **97**, 111503 (2010).

Objective

We demonstrate the efficient EUV source at 6.7 nm using Gd and Tb LPPs.

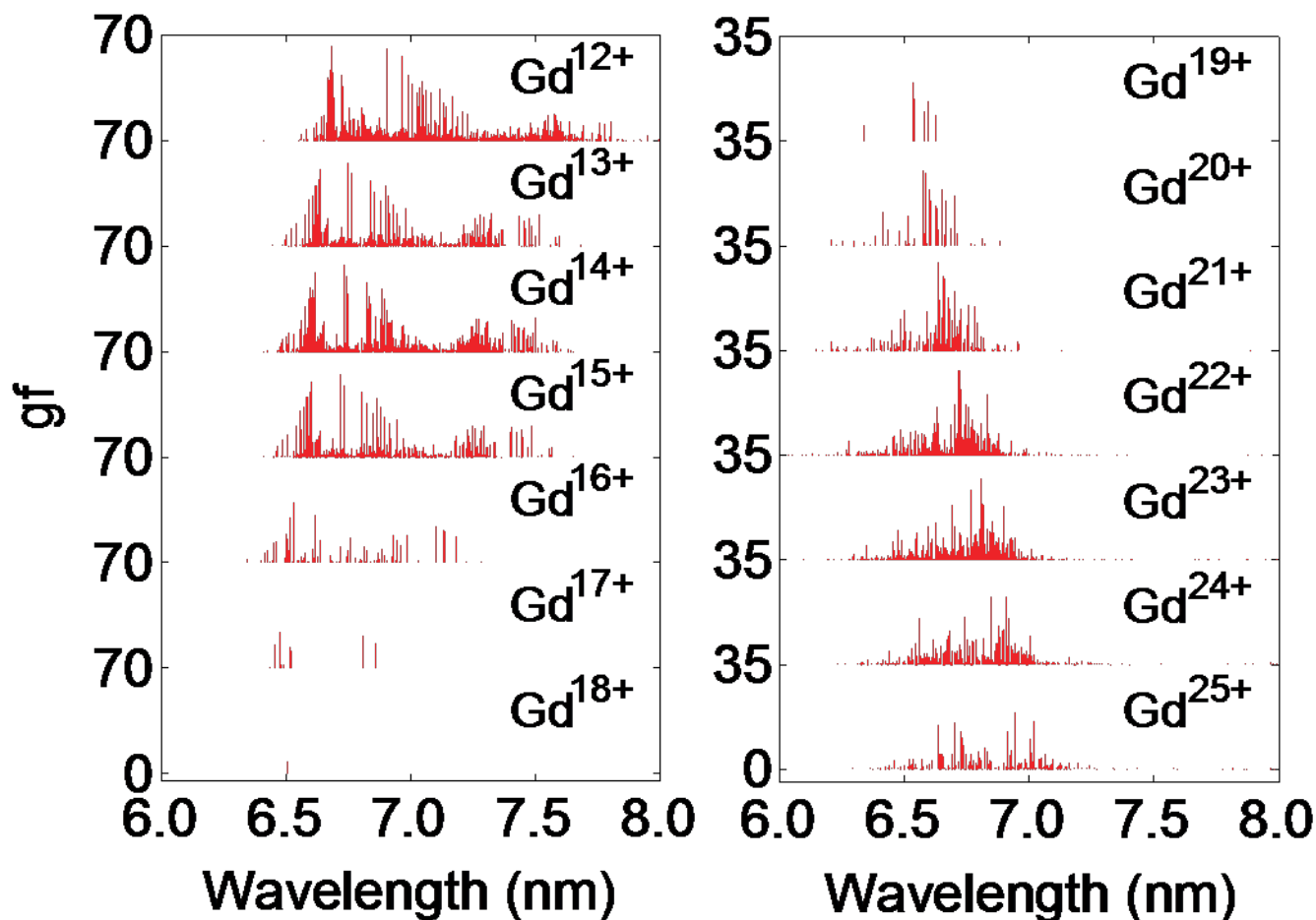
Ionic population of Gd ions

We should produce 50-150 eV plasma.



gf spectra of Gd ions

We confirm the UTA resonant lines around 6.7 nm

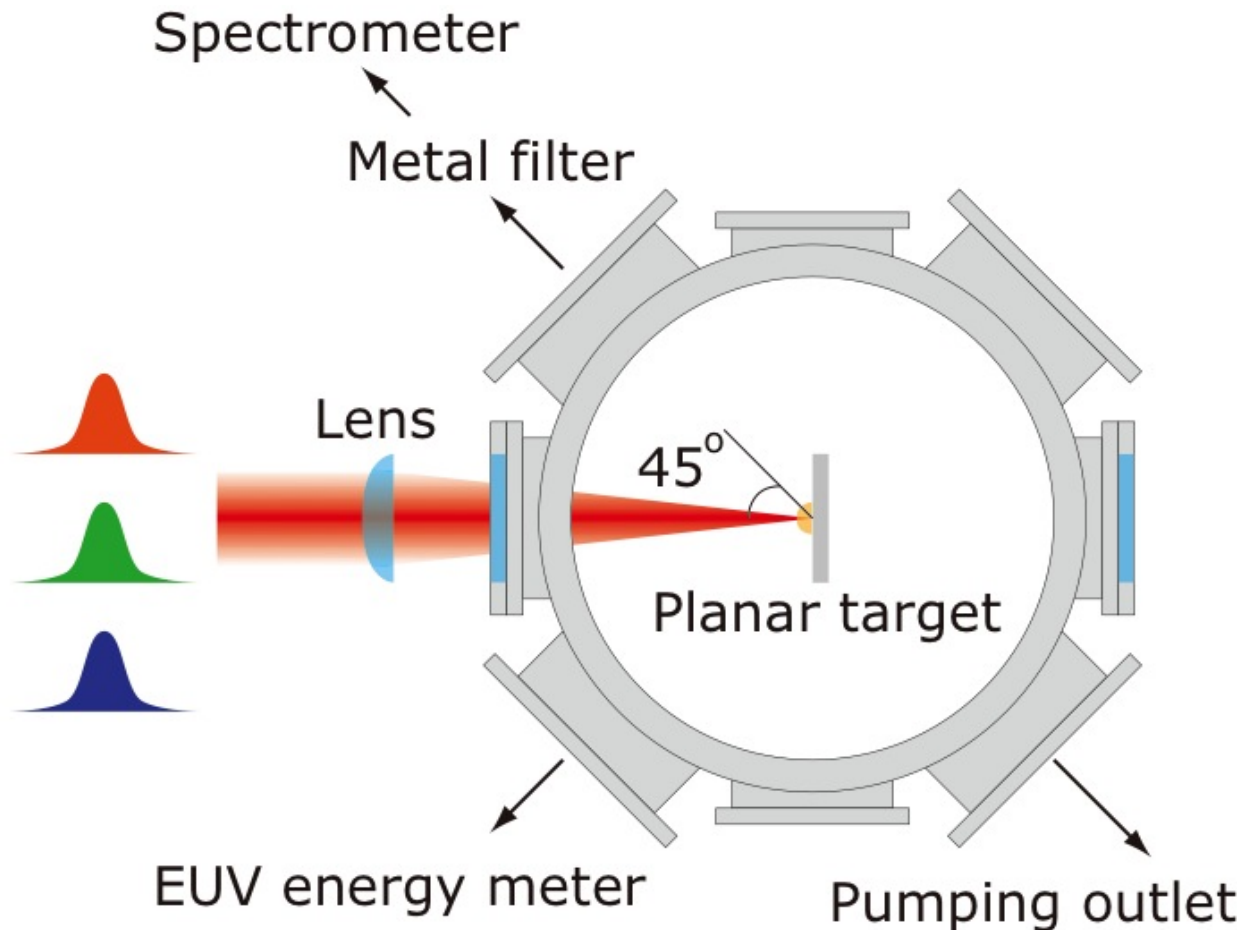


T. Otsuka *et al.*, APL **97**, 111503 (2010).

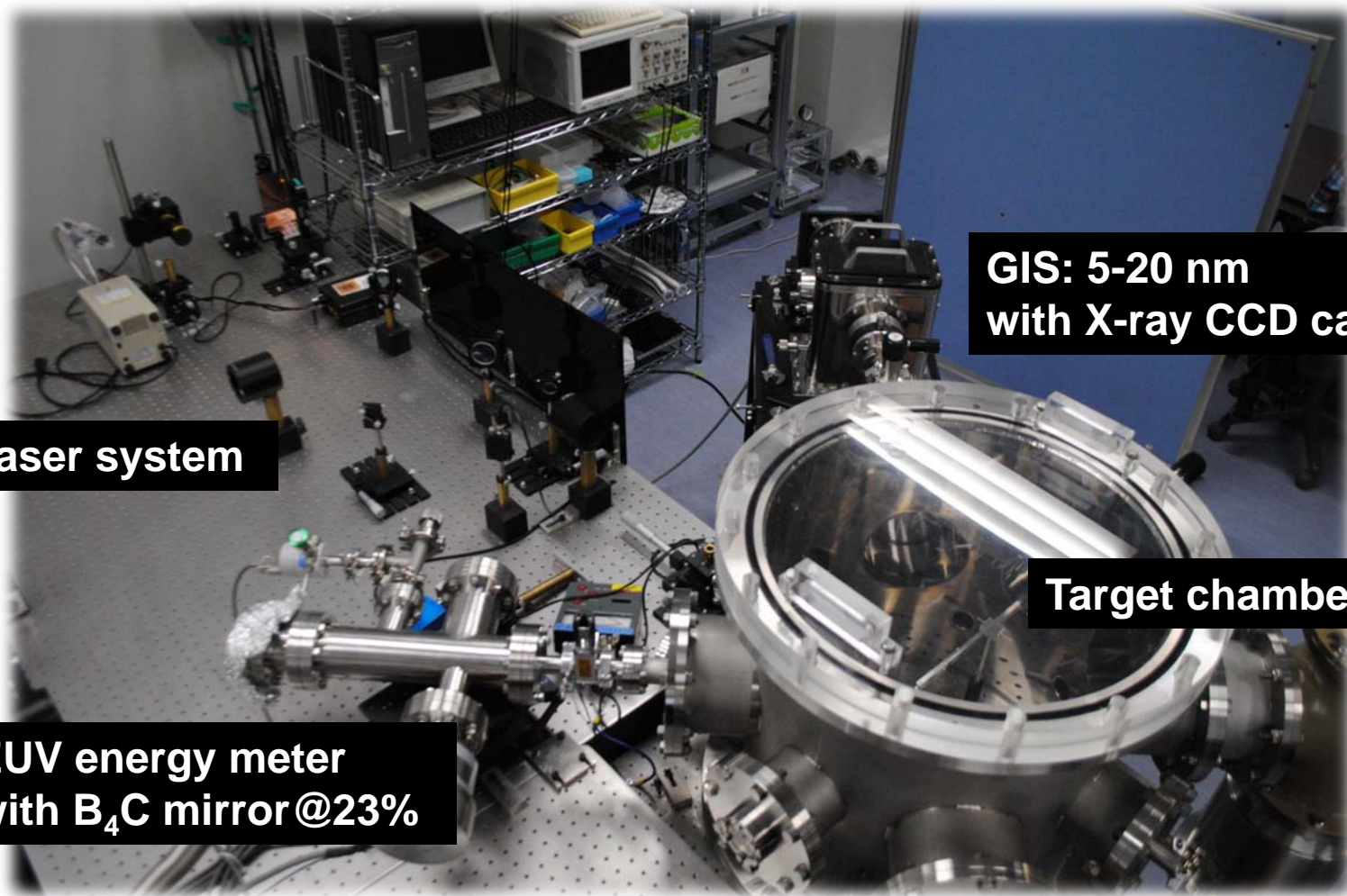
Experimental setup

Nd:YAG Laser

ω :	Laser energy: 2 J Wavelength: 1064 nm
2ω :	Laser energy: 1 J Wavelength: 532 nm
3ω :	Laser energy: 0.4 J Wavelength: 355 nm



Photograph of our setup



from Laser system

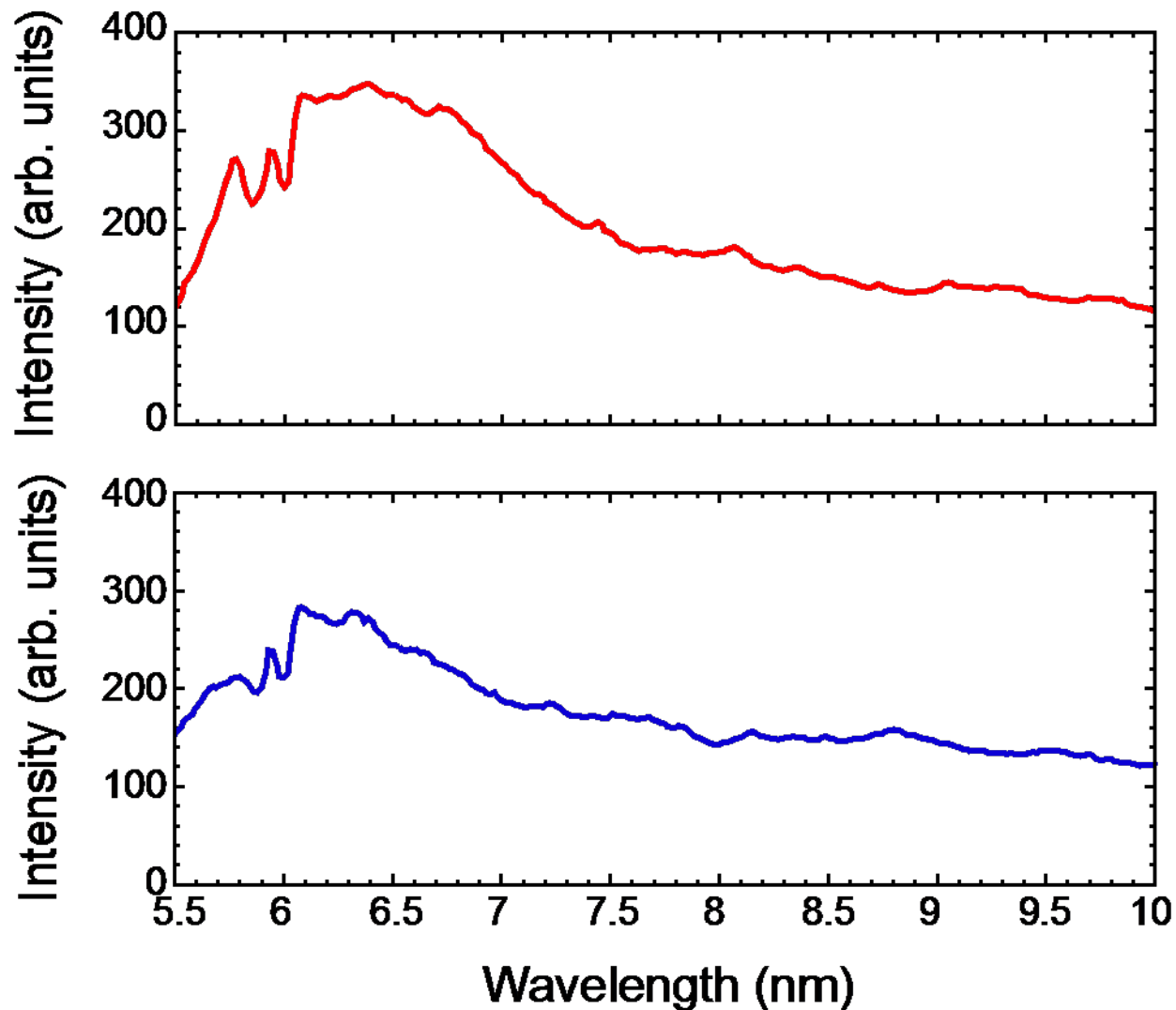
GIS: 5-20 nm
with X-ray CCD camera

Target chamber

EUV energy meter
with B₄C mirror@23%

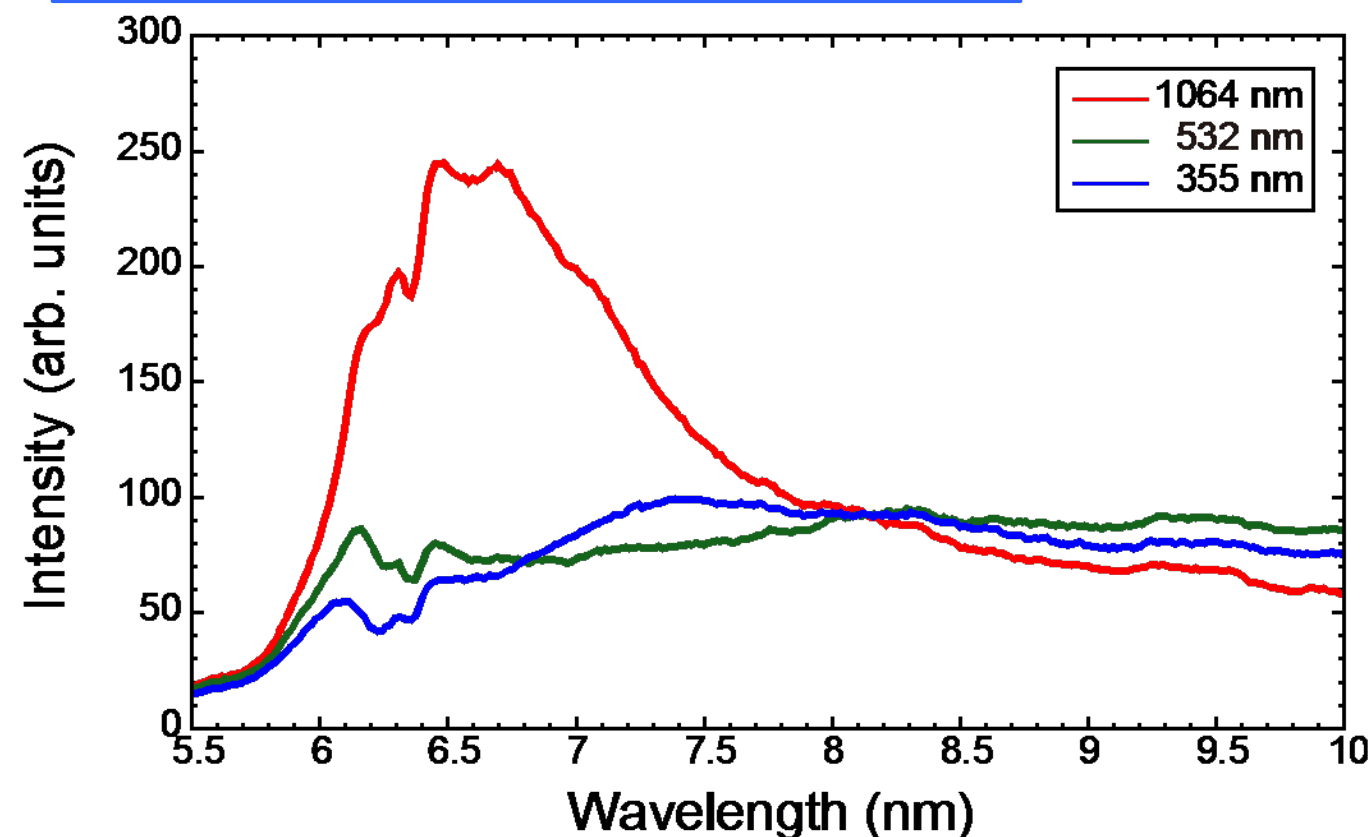
Spectral comparison Gd with Tb

We observed strong emission around 6.7 nm



Laser wavelength dependence

- Spot diameter: 50 μm (FWHM)
- Laser energy: 320 mJ
- Laser intensity: $1.6 \times 10^{12} \text{ W/cm}^2$



**EUV CEs
(in 2% BW)**

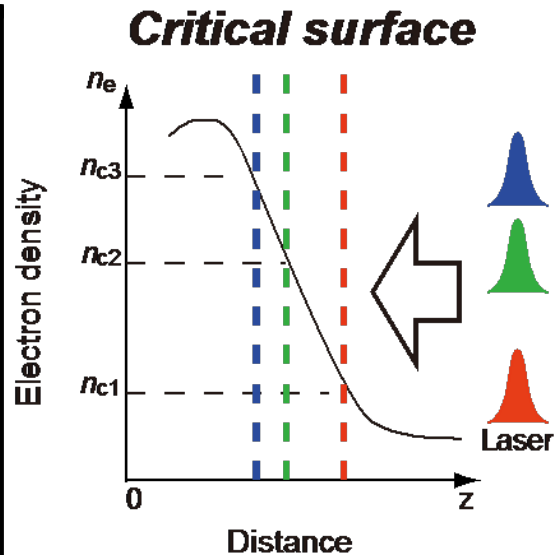
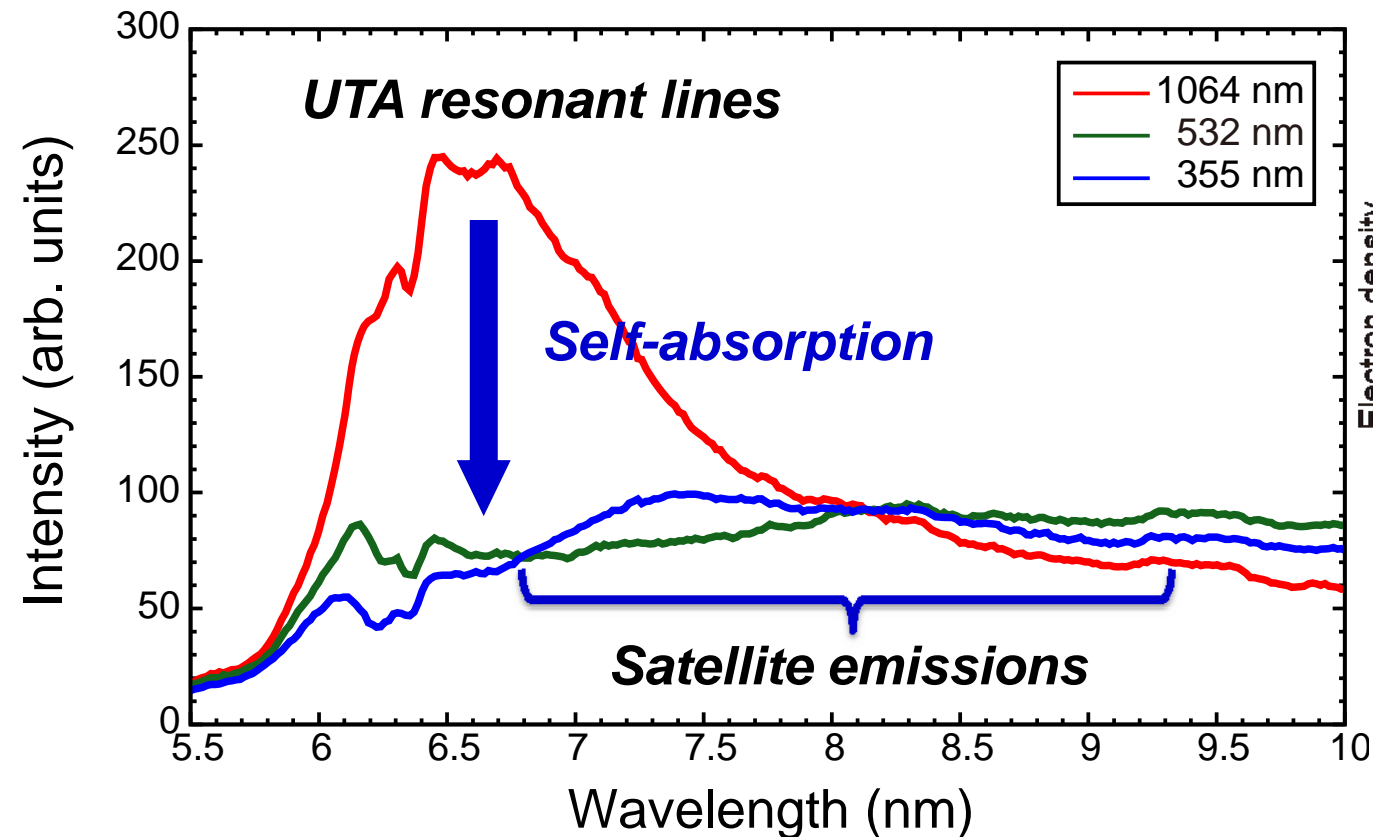
1064 nm: 1.1%

532 nm: 0.7%

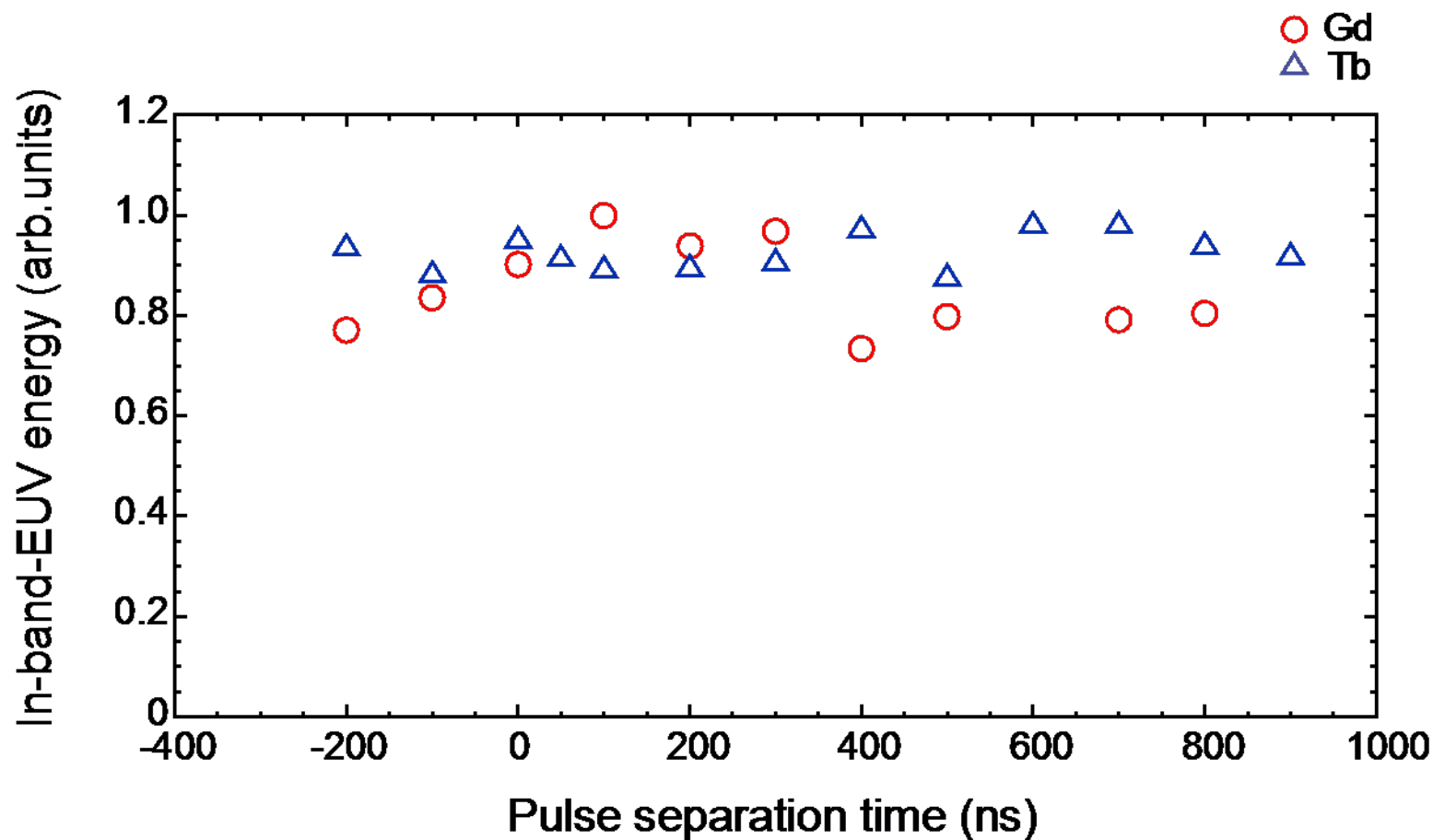
355 nm: 0.5%

Laser wavelength dependence

- Spot diameter: 50 μm (FWHM)
- Laser energy: 320 mJ
- Laser intensity: $1.6 \times 10^{12} \text{ W/cm}^2$



Dual laser pulse irradiation



Trade off 1

Effective ions vs self-absorption

Electron (ion) density decreases,
but ***absorption length increases.***

For large opacity material (high- Z), such as Xe & Sn

Electron density decreased: absorption effect decreased

Density gradient increased: absorption effect increased

**For small opacity material (low- Z),
such as Li & low initial density target**

Electron density decreased: absorption effect more decreased

Density gradient increased: large volume effect increased

Physical summary for high-Z plasmas from 13.5-nm Sn plasmas

Low density plasmas for reducing self-absorption effects

Suppression of satellite emission & higher spectral purity

Long wavelength (low critical density): CO₂ laser @ 10^{19} /cc

Short laser pulse duration: ~1-2 ns @ YAG laser (1064 nm)

Low density targets

Discharge plasmas (low density plasmas)

Effective dual pulse scheme

We require the use of:

low initial density target

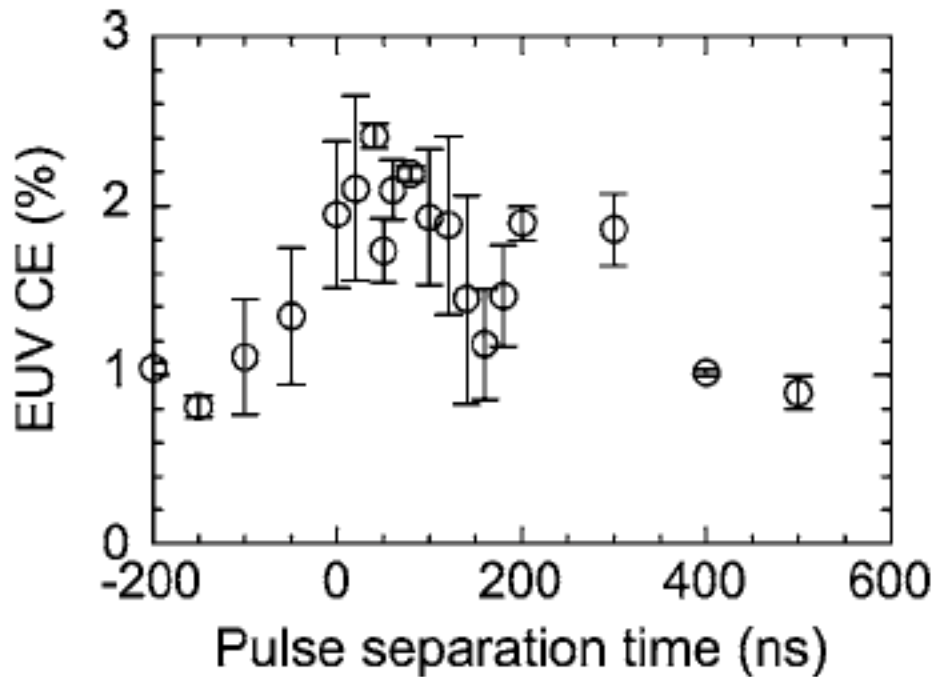
or

longer laser wavelength laser

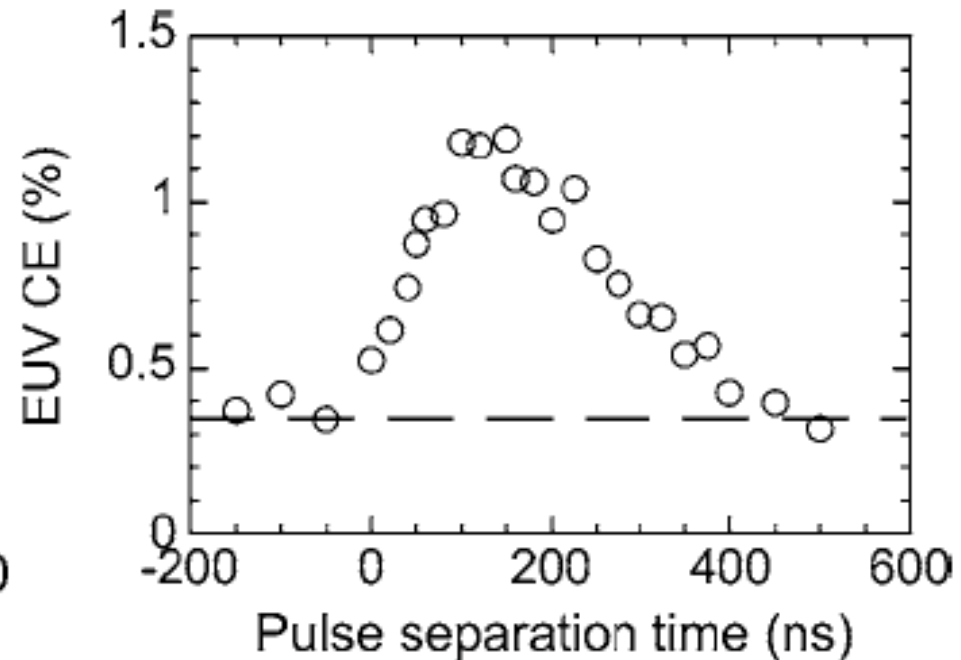
in the **self-absorption effect suppression** point of view.

Previous 13.5-nm dual laser pulse irradiation experiments

Low opacity: Li planar target



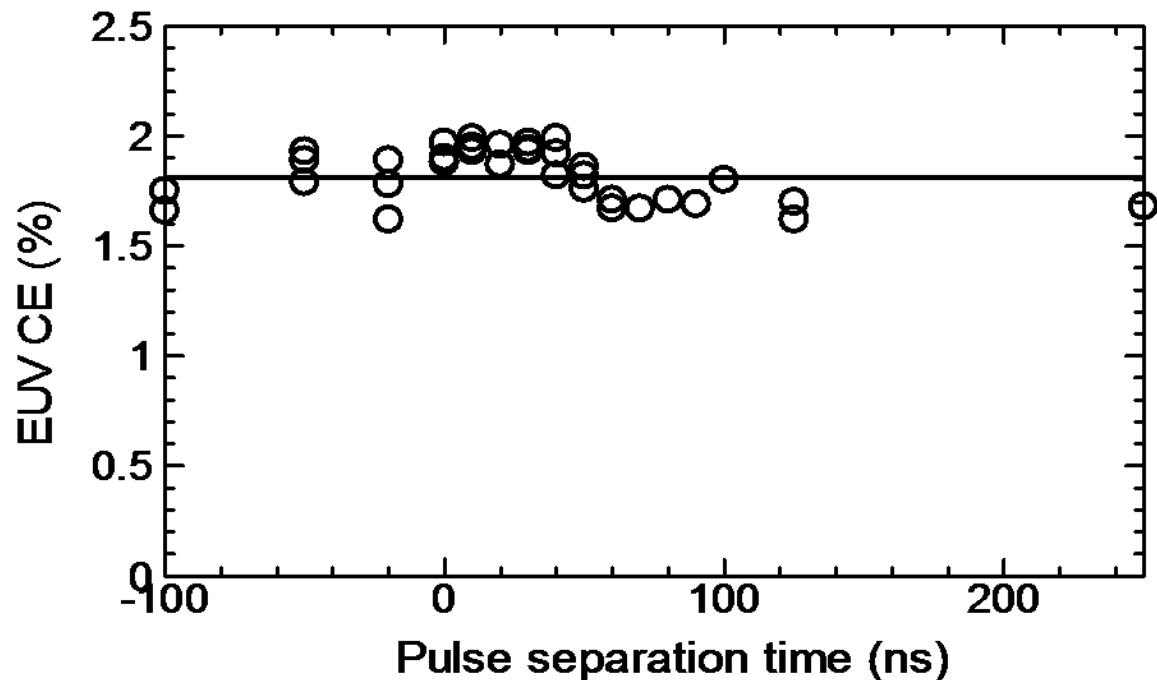
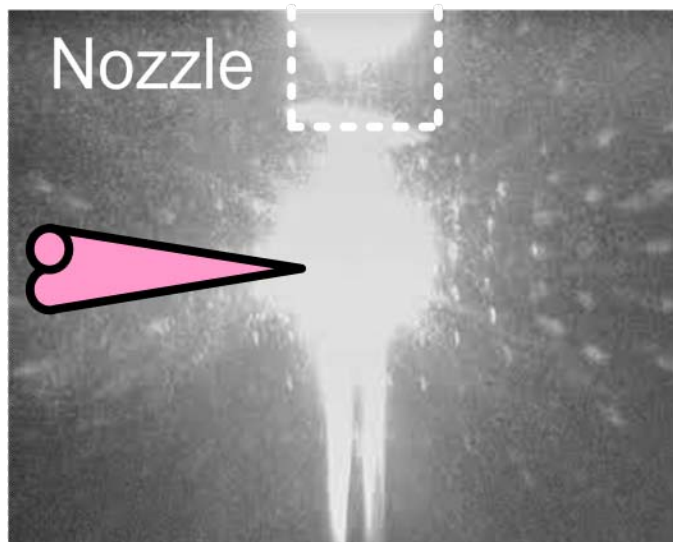
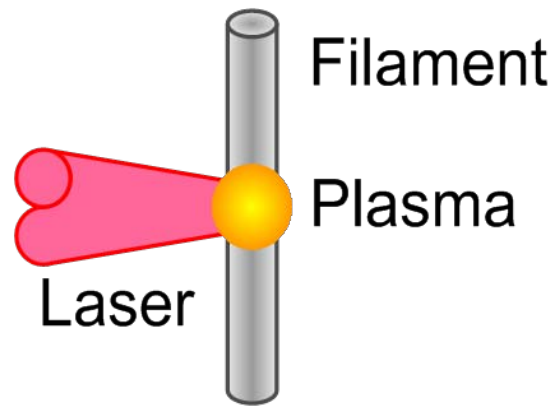
Low density: SnO₂ liquid target



T. Higashiguchi *et al.*, APL **88**, 161502 (2006).

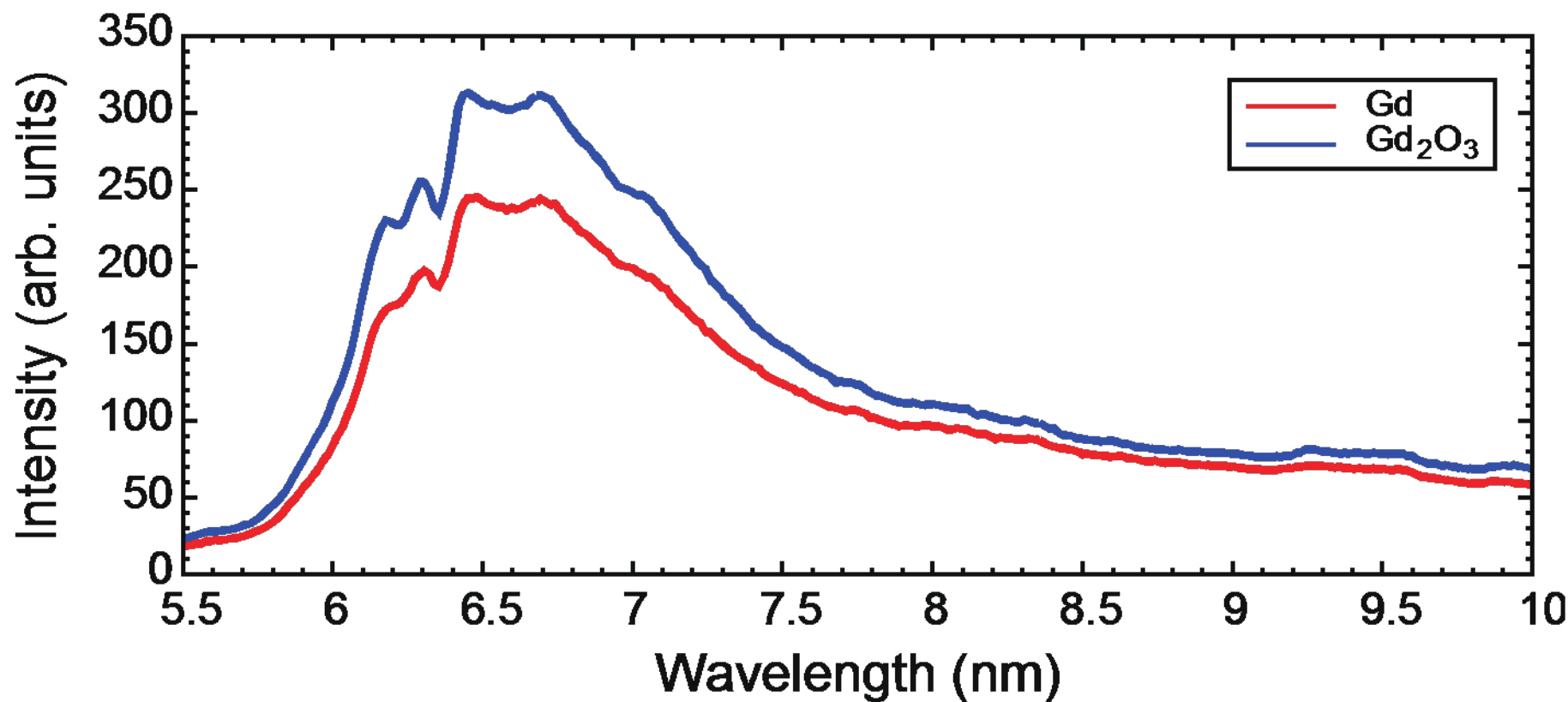
T. Higashiguchi *et al.*, APL **88**, 201503 (2006).

Previous 13.5-nm dual laser pulse irradiation experiments

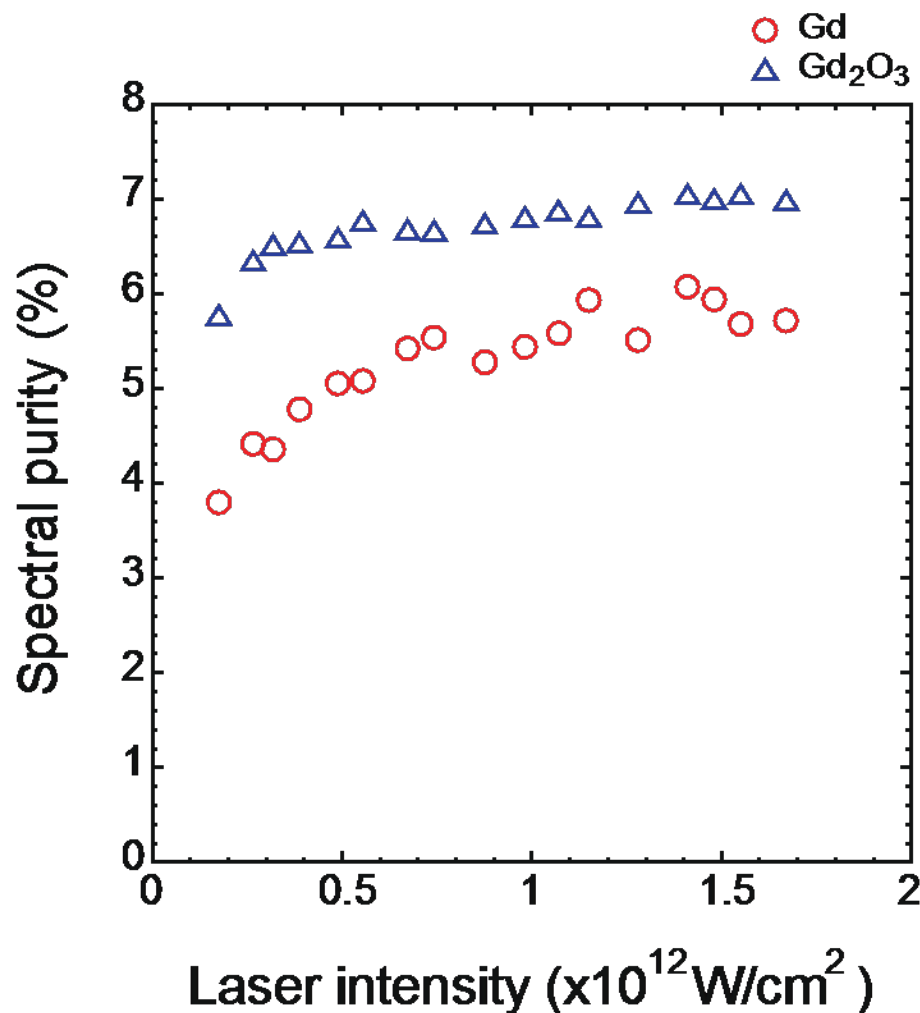


T. Higashiguchi *et al.*, RSI **78**, 036106 (2007).
T. Higashiguchi, (private communication, 2005).

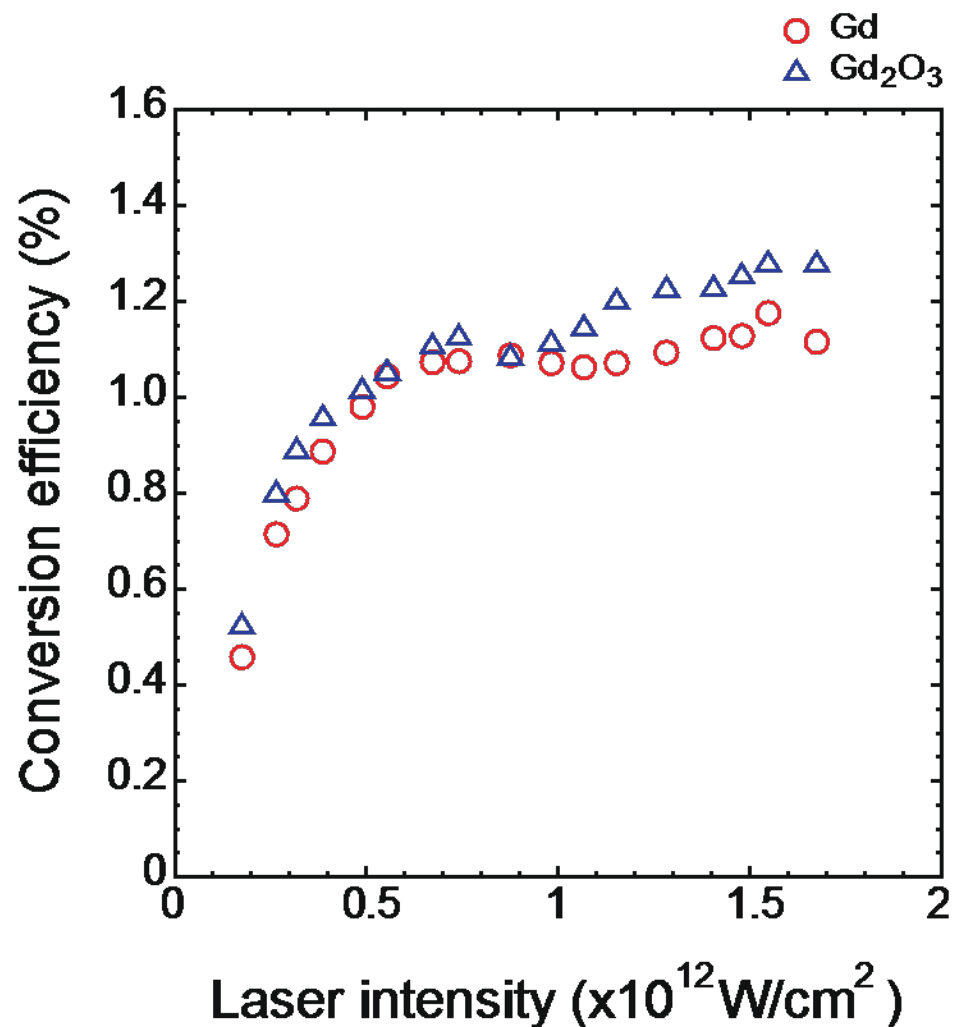
Target initial density dependence



Spectral purity



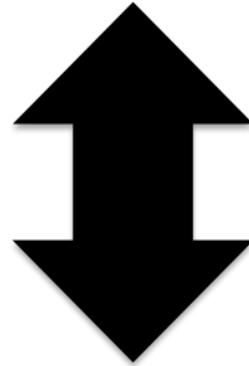
EUV CEs



Trade off 2

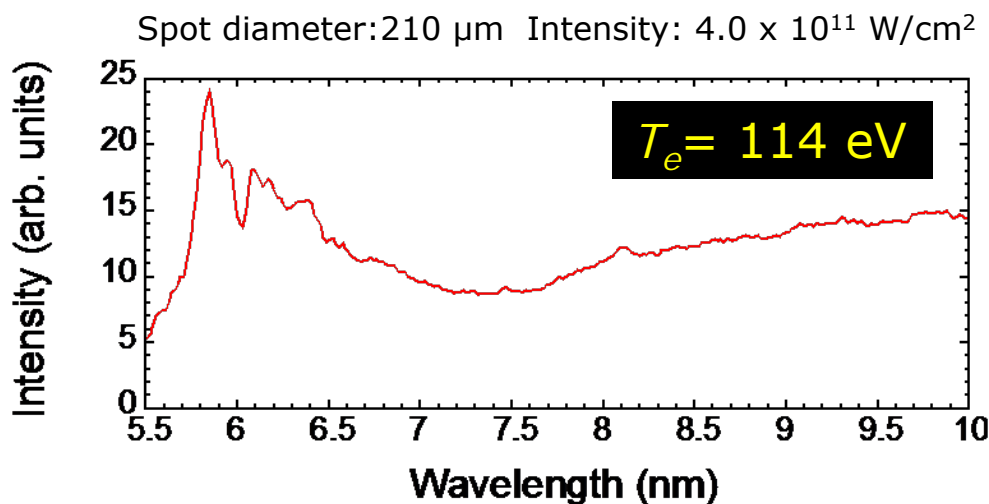
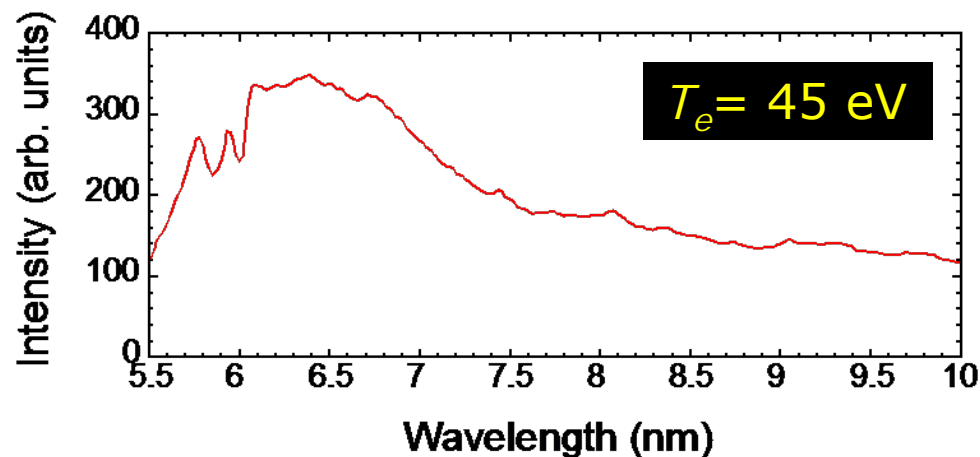
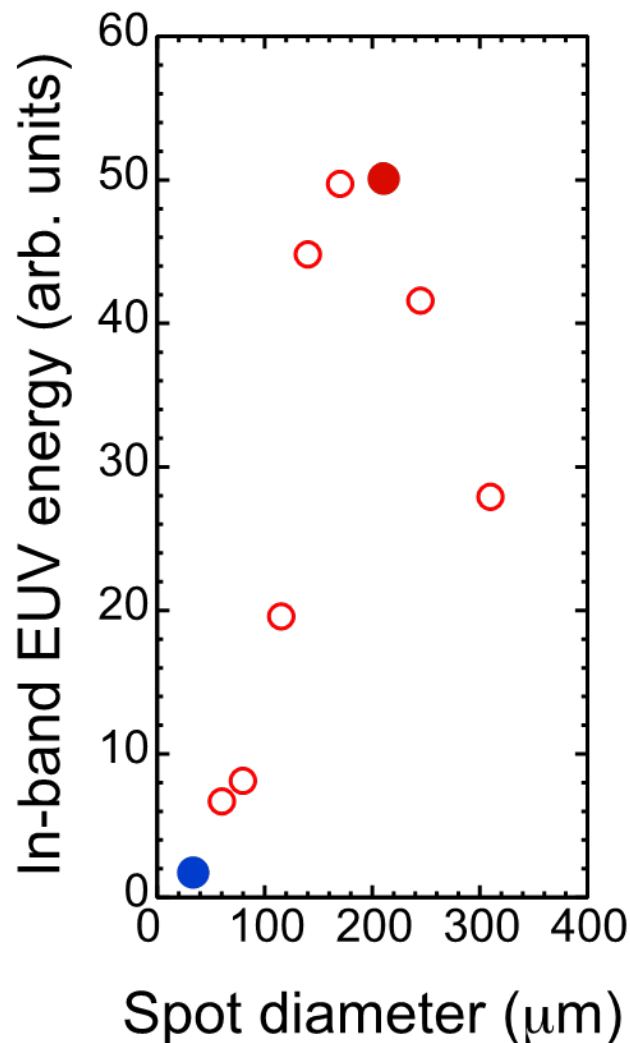
High electron temp vs plasma expansion loss

High T_e (50-150 eV) would be required
(small spot diameter)



Low expansion loss would be required
(large spot diameter)

Volume effect vs electron temperature



Spot diameter: 210 μm Intensity: $4.0 \times 10^{11} \text{ W/cm}^2$

Spot diameter: 35 μm Intensity: $1.5 \times 10^{13} \text{ W/cm}^2$

Question, problem, and definition...

- CO₂ laser-produced plasma behavior?
- High temperature (30-50 eV to 50-150 eV):
high energy particles
- CE bandwidth (2% to less than 0.1%?)

Summary

We have demonstrated the efficient EUV source around 6.7 nm using Gd & Tb (rare-earth).

- Spectral behavior at different laser wavelength
- Low density target to ***suppress the self-absorption*** in plasma
- Conversion efficiency: ~ **1.3%** before optimizing parameters
- Dominated ***plasma hydrodynamic expansion loss reduction***
- Question, problem, and definition

Related paper & poster

APPLIED PHYSICS LETTERS **97**, 111503 (2010)

Rare-earth plasma extreme ultraviolet sources at 6.5–6.7 nm

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We have demonstrated a laser-produced plasma extreme ultraviolet source operating in the 6.5–6.7 nm region based on rare-earth targets of Gd and Tb coupled with a Mo/B₄C multilayer mirror. Multiply charged ions produce strong resonance emission lines, which combine to yield an intense unresolved transition array. The spectra of these resonant lines around 6.7 nm (in-band: 6.7 nm \pm 1%) suggest that the in-band emission increases with increased plasma volume by suppressing the plasma hydrodynamic expansion loss at an electron temperature of about 50 eV, resulting in maximized emission. © 2010 American Institute of Physics. [doi:[10.1063/1.3490704](https://doi.org/10.1063/1.3490704)]

T. Otsuka *et al.*, APL **97**, 111503 (2010).

T. Otsuka *et al.*, (submitted).

Related paper & poster

Rare-earth plasmas as next generation extreme ultraviolet lithography sources at 6.5-6.7 nm

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